

# FU120N-VB Datasheet

## N-Channel 100-V (D-S) MOSFET

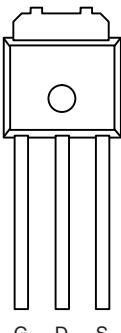
PRODUCT SUMMARY		
$V_{DS}$ (V)		100
$R_{DS(on)}$ ( $\Omega$ )	$V_{GS} = 10$ V	0.20
$Q_g$ (Max.) (nC)		16
$Q_{gs}$ (nC)		4.4
$Q_{gd}$ (nC)		7.7
Configuration		Single

### FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- 175 °C Operating Temperature
- Fast Switching
- Ease of Paralleling



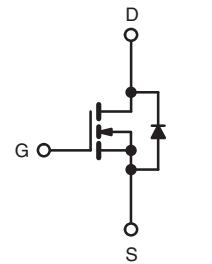
TO-251



Drain Connected to Drain-Tab

G D S

Top View



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ( $T_C = 25$ °C, unless otherwise noted)				
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		$V_{DS}$	100	V
Gate-Source Voltage		$V_{GS}$	$\pm 20$	
Continuous Drain Current	$V_{GS}$ at 10 V	$I_D$	12	A
			7.5	
Pulsed Drain Current <sup>a</sup>		$I_{DM}$	37	
Linear Derating Factor			0.40	W/°C
Linear Derating Factor (PCB Mount)			0.025	
Single Pulse Avalanche Energy <sup>b</sup>		$E_{AS}$	200	mJ
Avalanche Current <sup>a</sup>		$I_{AR}$	9.2	A
Repetitive Avalanche Energy <sup>a</sup>		$E_{AR}$	6.0	mJ
Maximum Power Dissipation	$T_C = 25$ °C	$P_D$	60	W
Maximum Power Dissipation (PCB Mount)	$T_A = 25$ °C		3.7	
Peak Diode Recovery dV/dt <sup>c</sup>		dV/dt	5.5	V/ns
Operating Junction and Storage Temperature Range		$T_J, T_{stg}$	- 55 to + 175	°C
Soldering Recommendations (Peak Temperature)	For 10 s		300 <sup>d</sup>	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b.  $V_{DD} = 25$  V, starting  $T_J = 25$  °C,  $L = 3.5$  mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 9.2$  A (see fig. 12).

c.  $I_{SD} \leq 9.2$  A,  $dI/dt \leq 110$  A/ $\mu$ s,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 175$  °C.

<b>THERMAL RESISTANCE RATINGS</b>				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	$R_{thJA}$	-	62	$^{\circ}\text{C}/\text{W}$
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	$R_{thJA}$	-	40	
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	2.5	

<b>SPECIFICATIONS</b> ( $T_J = 25 \text{ }^{\circ}\text{C}$ , unless otherwise noted)								
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
<b>Static</b>								
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0$ , $I_D = 250 \mu\text{A}$		100	-	-	V	
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to $25 \text{ }^{\circ}\text{C}$ , $I_D = 1 \text{ mA}$		-	0.13	-	$\text{V}/^{\circ}\text{C}$	
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$		1.0	-	3.0	V	
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 20 \text{ V}$		-	-	$\pm 100$	nA	
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 100 \text{ V}$ , $V_{GS} = 0 \text{ V}$		-	-	25	$\mu\text{A}$	
		$V_{DS} = 80 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $T_J = 150 \text{ }^{\circ}\text{C}$		-	-	250		
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 10 \text{ V}$	$I_D = 5.5 \text{ A}^b$	-	0.20	-	$\Omega$	
Forward Transconductance	$g_{fs}$	$V_{DS} = 50 \text{ V}$ , $I_D = 5.5 \text{ A}^b$		2.7	-	-	S	
<b>Dynamic</b>								
Input Capacitance	$C_{iss}$	$V_{GS} = 0 \text{ V}$ , $V_{DS} = 25 \text{ V}$ , $f = 1.0 \text{ MHz}$ , see fig. 5		-	360	-	pF	
Output Capacitance	$C_{oss}$			-	150	-		
Reverse Transfer Capacitance	$C_{rss}$			-	34	-		
Total Gate Charge	$Q_g$	$V_{GS} = 10 \text{ V}$	$I_D = 9.2 \text{ A}$ , $V_{DS} = 80 \text{ V}$ , see fig. 6 and 13 <sup>b</sup>	-	-	16	nC	
Gate-Source Charge	$Q_{gs}$			-	-	4.4		
Gate-Drain Charge	$Q_{gd}$			-	-	7.7		
Turn-On Delay Time	$t_{d(on)}$			-	8.8	-		
Rise Time	$t_r$	$V_{DD} = 50 \text{ V}$ , $I_D = 9.2 \text{ A}$ , $R_g = 18 \Omega$ , $R_D = 5.2 \Omega$ , see fig. 10 <sup>b</sup>		-	30	-	ns	
Turn-Off Delay Time	$t_{d(off)}$			-	19	-		
Fall Time	$t_f$			-	20	-		
Internal Drain Inductance	$L_D$			-	4.5	-	nH	
Internal Source Inductance	$L_S$	Between lead, 6 mm (0.25") from package and center of die contact		-	7.5	-		
<b>Drain-Source Body Diode Characteristics</b>								
Continuous Source-Drain Diode Current	$I_S$	MOSFET symbol showing the integral reverse p - n junction diode		-	-	9.2	A	
Pulsed Diode Forward Current <sup>a</sup>	$I_{SM}$			-	-	37		
Body Diode Voltage	$V_{SD}$	$T_J = 25 \text{ }^{\circ}\text{C}$ , $I_S = 9.2 \text{ A}$ , $V_{GS} = 0 \text{ V}^b$		-	-	1.8	V	
Body Diode Reverse Recovery Time	$t_{rr}$	$T_J = 25 \text{ }^{\circ}\text{C}$ , $I_F = 9.2 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	110	260	ns	
Body Diode Reverse Recovery Charge	$Q_{rr}$			-	0.53	1.3	$\mu\text{C}$	
Forward Turn-On Time	$t_{on}$	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )						

**Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).  
b. Pulse width  $\leq 300 \mu\text{s}$ ; duty cycle  $\leq 2 \%$ .

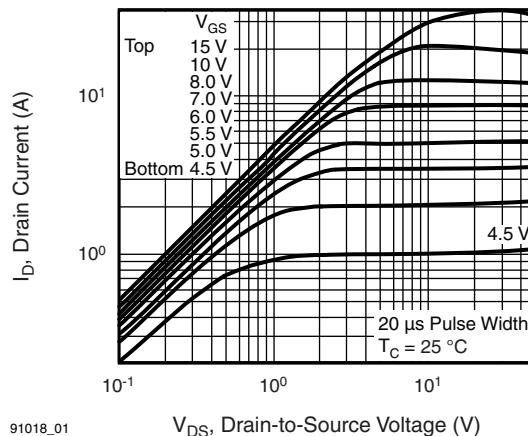
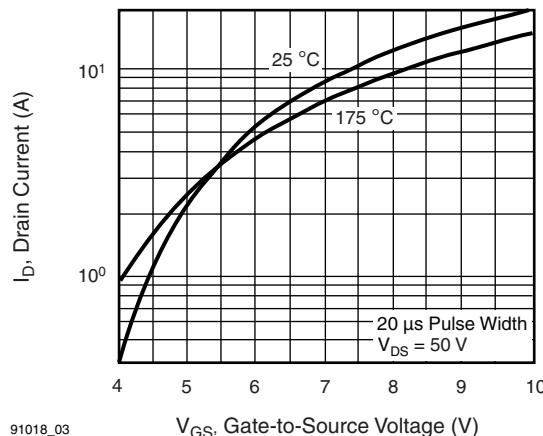
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)Fig. 1 - Typical Output Characteristics,  $T_C = 25 \text{ }^\circ\text{C}$ 

Fig. 3 - Typical Transfer Characteristics

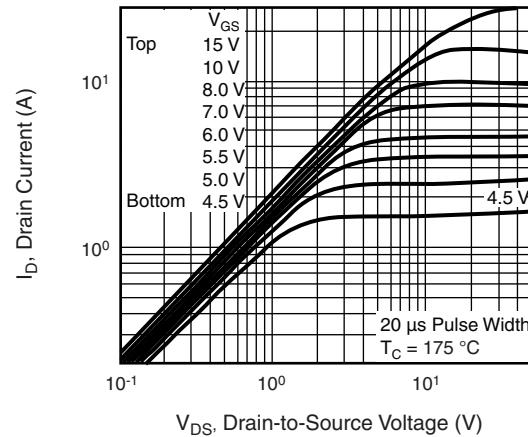
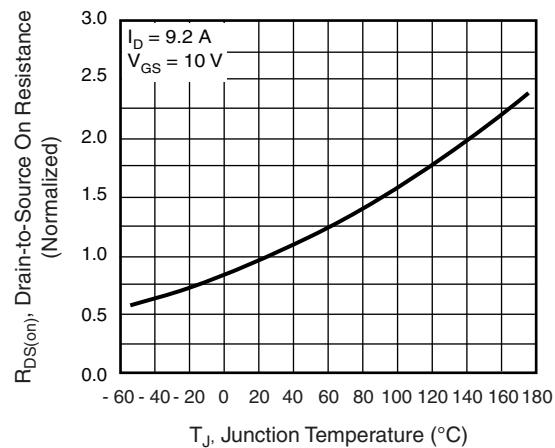
Fig. 2 - Typical Output Characteristics,  $T_C = 175 \text{ }^\circ\text{C}$ 

Fig. 4 - Normalized On-Resistance vs. Temperature

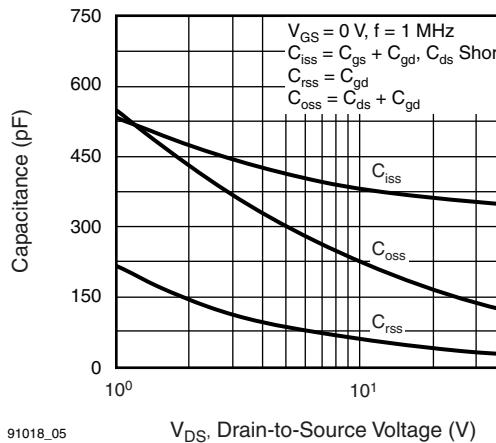


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

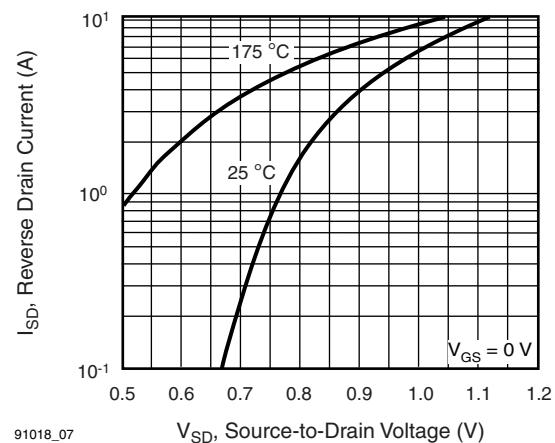


Fig. 7 - Typical Source-Drain Diode Forward Voltage

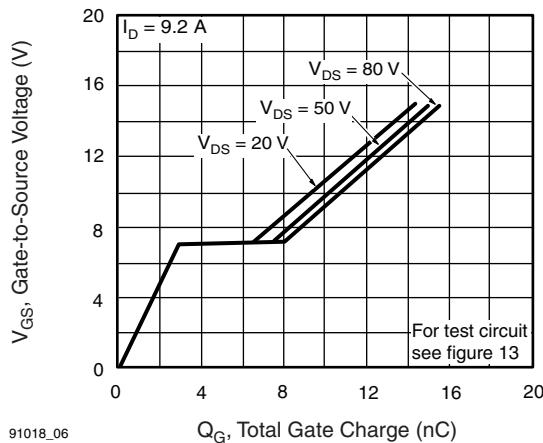


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

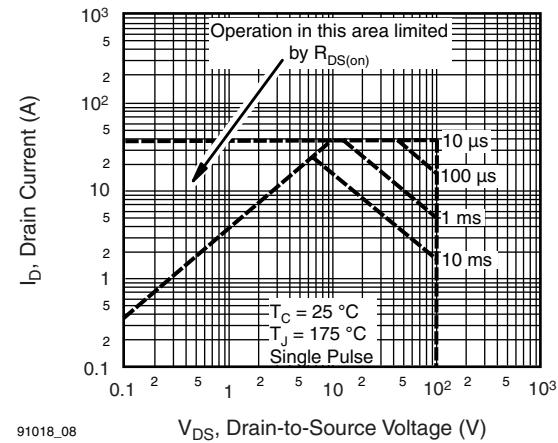


Fig. 8 - Maximum Safe Operating Area

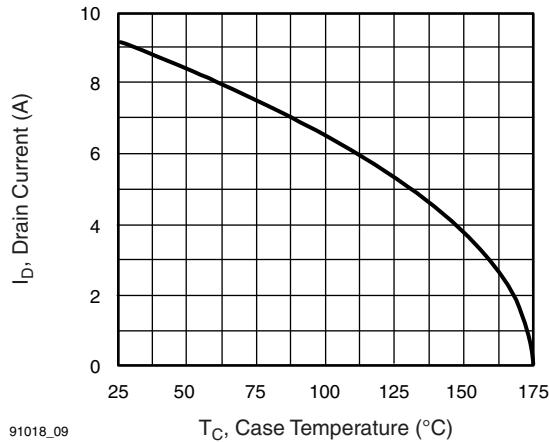


Fig. 9 - Maximum Drain Current vs. Case Temperature

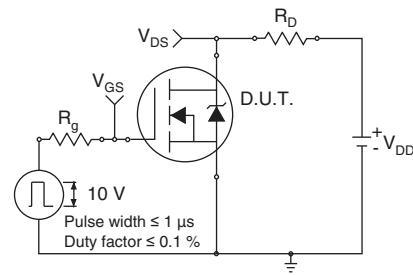


Fig. 10a - Switching Time Test Circuit

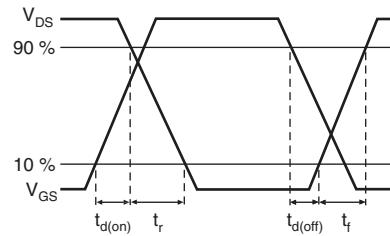


Fig. 10b - Switching Time Waveforms

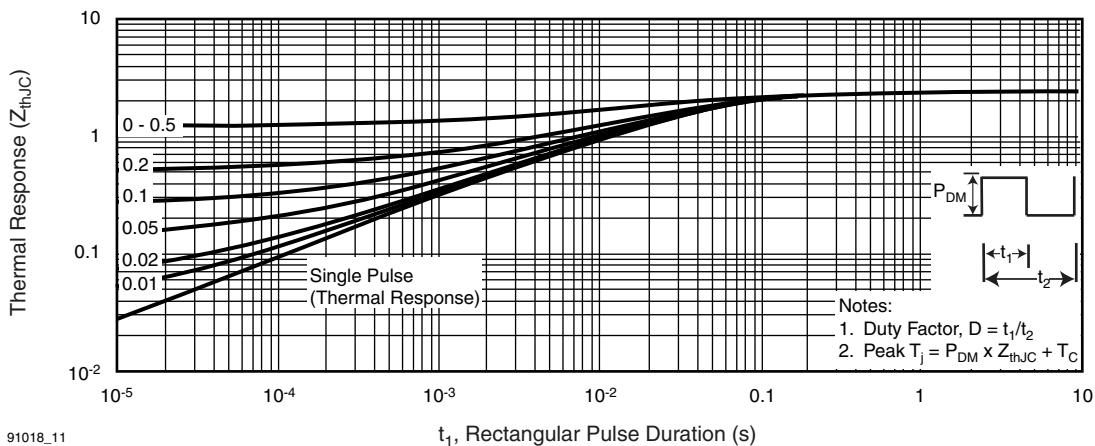


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

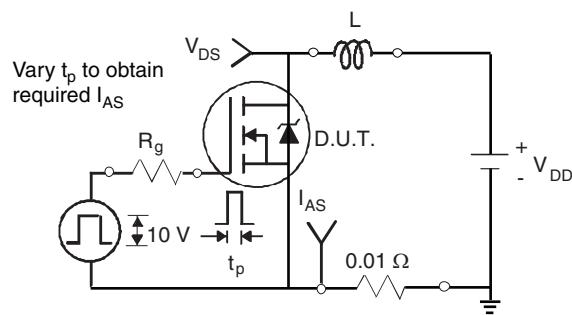


Fig. 12a - Unclamped Inductive Test Circuit

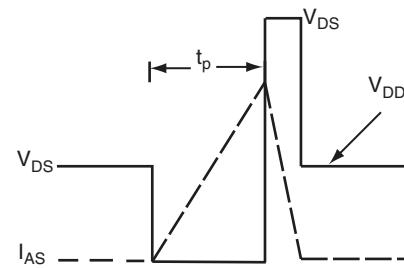


Fig. 12b - Unclamped Inductive Waveforms

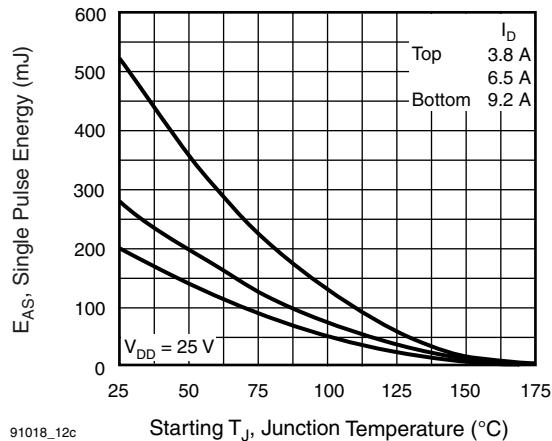


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

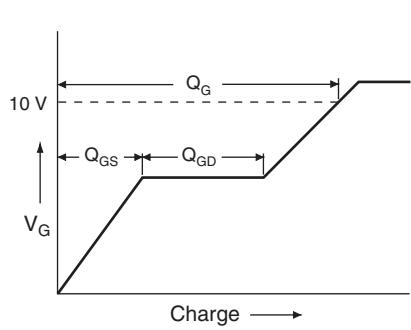


Fig. 13a - Basic Gate Charge Waveform

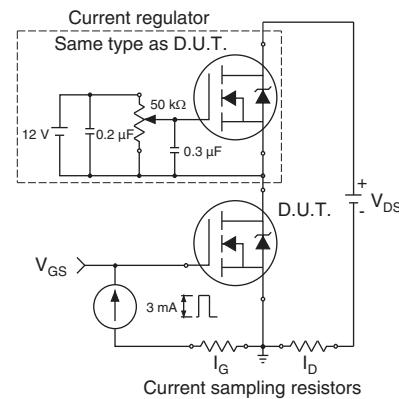
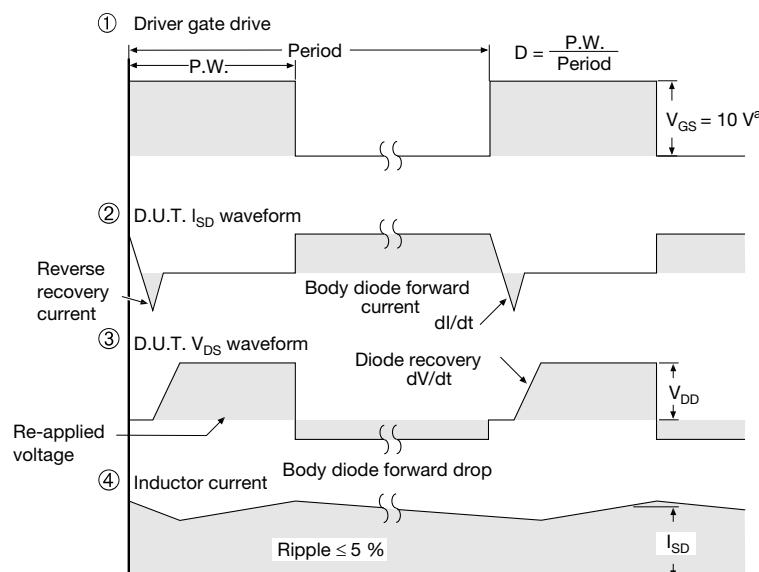
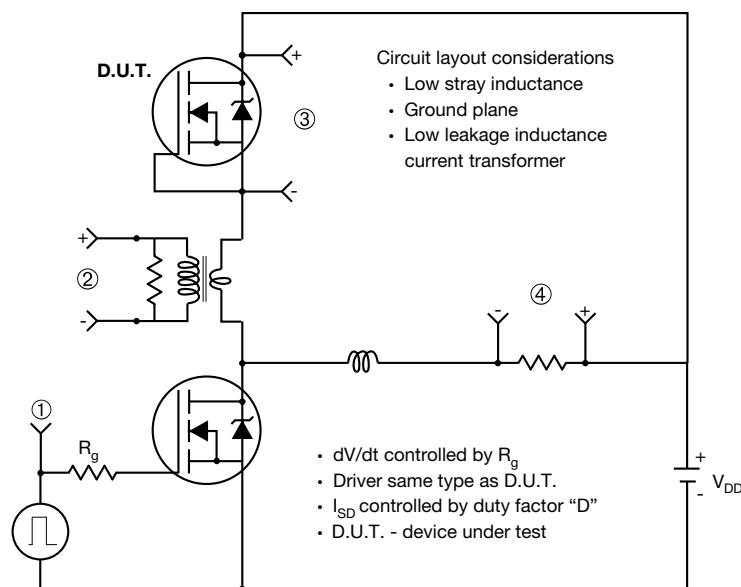
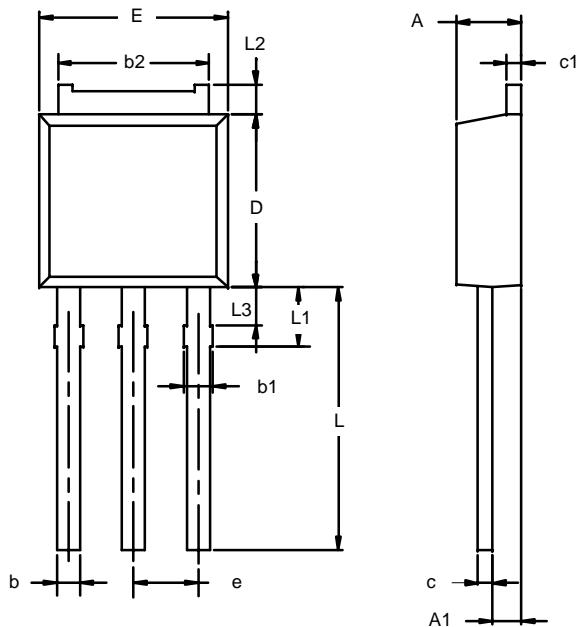


Fig. 13b - Gate Charge Test Circuit

**Peak Diode Recovery dV/dt Test Circuit**
**Note**a.  $V_{GS} = 5 \text{ V}$  for logic level devices**Fig. 14 - For N-Channel**

**TO-251AA**

Dim	MILLIMETERS		INCHES	
	Min	Max	Min	Max
<b>A</b>	2.21	2.38	0.087	0.094
<b>A1</b>	0.89	1.14	0.035	0.045
<b>b</b>	0.71	0.89	0.028	0.035
<b>b1</b>	0.76	1.14	0.030	0.045
<b>b2</b>	5.23	5.43	0.206	0.214
<b>c</b>	0.46	0.58	0.018	0.023
<b>c1</b>	0.46	0.58	0.018	0.023
<b>D</b>	5.97	6.22	0.235	0.245
<b>E</b>	6.48	6.73	0.255	0.265
<b>e</b>	2.28 BSC		0.090 BSC	
<b>L</b>	3.89	9.53	0.153	0.375
<b>L1</b>	1.91	2.28	0.075	0.090
<b>L2</b>	0.89	1.27	0.035	0.050
<b>L3</b>	1.15	1.52	0.045	0.060

Note: Dimension L3 is for reference only.

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